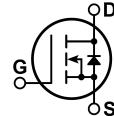


## N-Channel FREDFET

Power MOS 8™ is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced  $t_{rr}$ , soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of  $C_{rss}/C_{iss}$  result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



Single die FREDFET



### FEATURES

- Fast switching with low EMI
- Low  $t_{rr}$  for high reliability
- Ultra low  $C_{rss}$  for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant 

### TYPICAL APPLICATIONS

- ZVS phase shifted and other full bridge
- Half bridge
- PFC and other boost converter
- Buck converter
- Single and two switch forward
- Flyback

### Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
$I_D$	Continuous Drain Current @ $T_C = 25^\circ\text{C}$	84	A
	Continuous Drain Current @ $T_C = 100^\circ\text{C}$	52	
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	447	
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulse Avalanche Energy <sup>②</sup>	3352	mJ
$I_{AR}$	Avalanche Current, Repetitive or Non-Repetitive	60	A

### Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Typ	Max	Unit
$P_D$	Total Power Dissipation @ $T_C = 25^\circ\text{C}$			961	W
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.13	$^\circ\text{C}/\text{W}$
$R_{\theta CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15		
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55		150	$^\circ\text{C}$
$V_{Isolation}$	RMS Voltage (50-60Hz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)	2500			V
$W_T$	Package Weight		1.03		oz
			29.2		g
Torque	Terminals and Mounting Screws.			10	$\text{in}\cdot\text{lbf}$
				1.1	N·m

## Static Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

APT80F60J

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$V_{BR(DSS)}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu\text{A}$	600			V
$\Delta V_{BR(DSS)}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}, I_D = 250\mu\text{A}$		0.60		$\text{V}/^\circ\text{C}$
$R_{DS(on)}$	Drain-Source On Resistance <sup>③</sup>	$V_{GS} = 10V, I_D = 60\text{A}$		0.042	0.055	$\Omega$
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 2.5\text{mA}$	2.5	4	5	V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold Voltage Temperature Coefficient			-10		$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600V, T_J = 25^\circ\text{C}$			250	$\mu\text{A}$
		$V_{GS} = 0V, T_J = 125^\circ\text{C}$			1000	
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			$\pm 100$	nA

## Dynamic Characteristics

$T_J = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$g_{fs}$	Forward Transconductance	$V_{DS} = 50V, I_D = 60\text{A}$		117		S
$C_{iss}$	Input Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ $f = 1\text{MHz}$		23994		pF
$C_{rss}$	Reverse Transfer Capacitance			245		
$C_{oss}$	Output Capacitance			2201		
$C_{o(cr)}^{\text{④}}$	Effective Output Capacitance, Charge Related	$V_{GS} = 0V, V_{DS} = 0V$ to $400V$		1170		nC
$C_{o(er)}^{\text{⑤}}$	Effective Output Capacitance, Energy Related			606		
$Q_g$	Total Gate Charge	$V_{GS} = 0$ to $10V, I_D = 60\text{A}$ , $V_{DS} = 300V$		598		ns
$Q_{gs}$	Gate-Source Charge			128		
$Q_{gd}$	Gate-Drain Charge			251		
$t_{d(on)}$	Turn-On Delay Time	<b>Resistive Switching</b> $V_{DD} = 400V, I_D = 60\text{A}$ $R_G = 2.2\Omega^{\text{⑥}}$ , $V_{GG} = 15V$		134		ns
$t_r$	Current Rise Time			156		
$t_{d(off)}$	Turn-Off Delay Time			408		
$t_f$	Current Fall Time			123		

## Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$I_s$	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode (body diode)			84	A
$I_{SM}$	Pulsed Source Current (Body Diode) <sup>①</sup>				447	
$V_{SD}$	Diode Forward Voltage	$I_{SD} = 60\text{A}, T_J = 25^\circ\text{C}, V_{GS} = 0V$			1.2	V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 60\text{A}^{\text{③}}$ $V_{DD} = 100V$ $di_{SD}/dt = 100\text{A}/\mu\text{s}$	$T_J = 25^\circ\text{C}$		370	ns
			$T_J = 125^\circ\text{C}$		690	
$Q_{rr}$	Reverse Recovery Charge	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	$T_J = 25^\circ\text{C}$	2.6		$\mu\text{C}$
			$T_J = 125^\circ\text{C}$	7.0		
$I_{rrm}$	Reverse Recovery Current	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	$T_J = 25^\circ\text{C}$	14.5		A
			$T_J = 125^\circ\text{C}$	20		
$dv/dt$	Peak Recovery dv/dt	$I_{SD} \leq 60\text{A}, di/dt \leq 1000\text{A}/\mu\text{s}, V_{DD} = 400V$ , $T_J = 125^\circ\text{C}$			25	V/ns

1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

2 Starting at  $T_J = 25^\circ\text{C}$ ,  $L = 2.08\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 60\text{A}$ .

3 Pulse test: Pulse Width < 380μs, duty cycle < 2%.

4  $C_{o(cr)}$  is defined as a fixed capacitance with the same stored charge as  $C_{OSS}$  with  $V_{DS} = 67\%$  of  $V_{(BR)DSS}$ .

5  $C_{o(er)}$  is defined as a fixed capacitance with the same stored energy as  $C_{OSS}$  with  $V_{DS} = 67\%$  of  $V_{(BR)DSS}$ . To calculate  $C_{o(er)}$  for any value of  $V_{DS}$  less than  $V_{(BR)DSS}$ , use this equation:  $C_{o(er)} = -3.14E-7/V_{DS}^{1.2} + 7.31E-8/V_{DS} + 2.09E-10$ .

6  $R_G$  is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

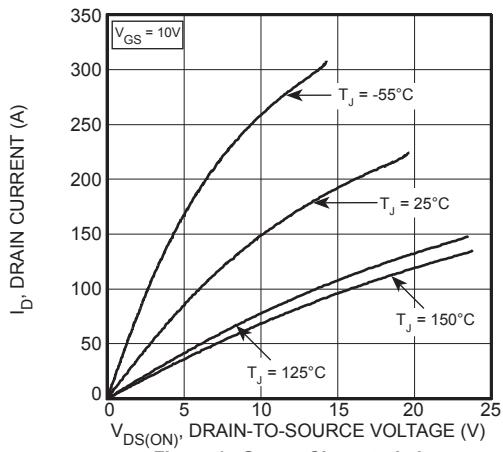


Figure 1, Output Characteristics

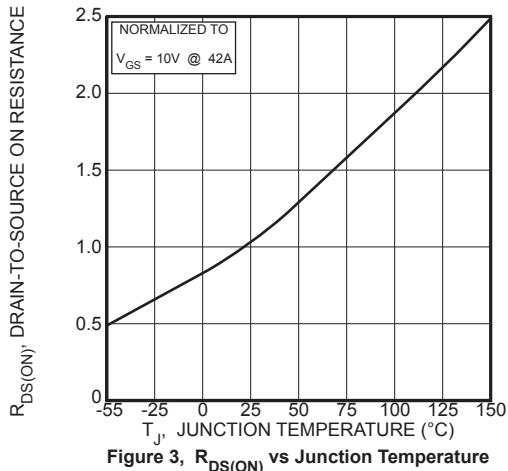
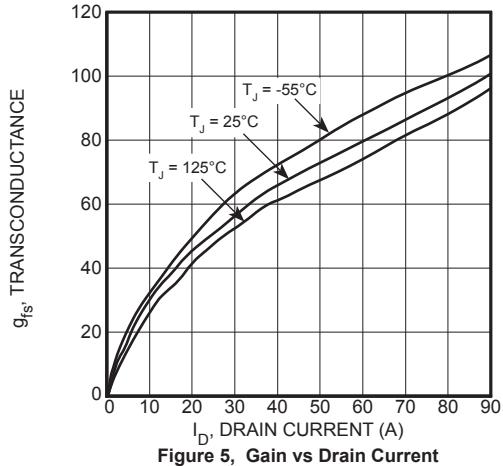
Figure 3,  $R_{DS(ON)}$  vs Junction Temperature

Figure 5, Gain vs Drain Current

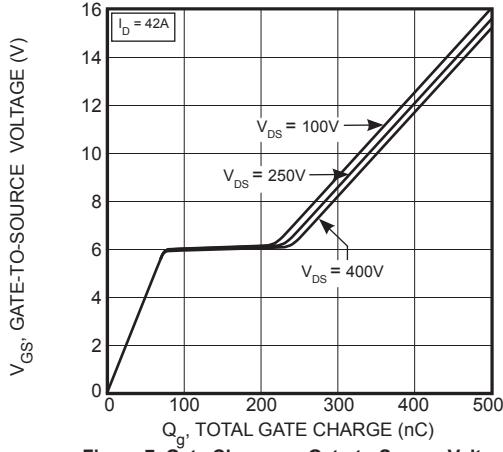


Figure 7, Gate Charge vs Gate-to-Source Voltage

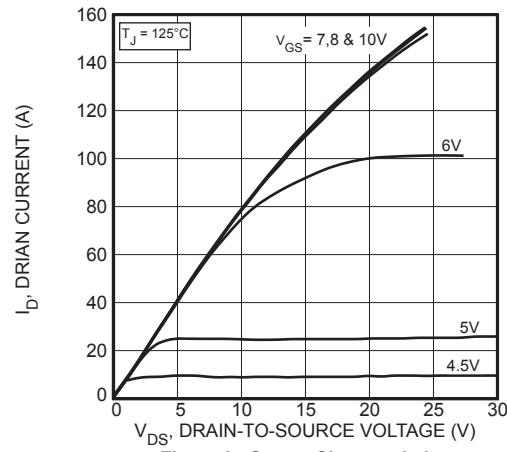


Figure 2, Output Characteristics

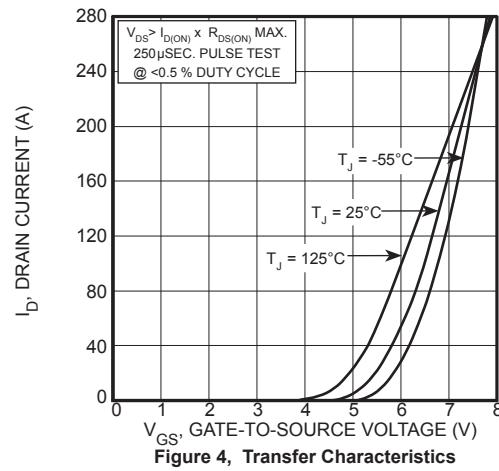


Figure 4, Transfer Characteristics

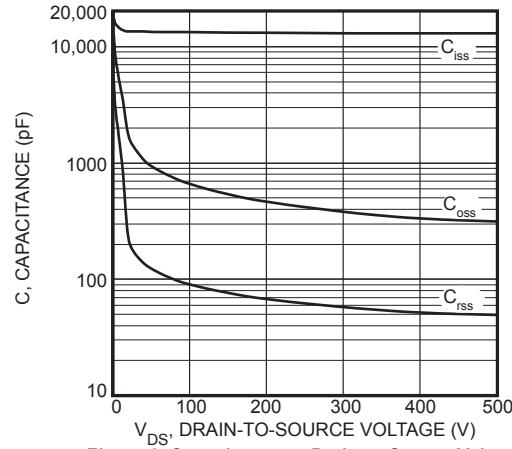


Figure 6, Capacitance vs Drain-to-Source Voltage

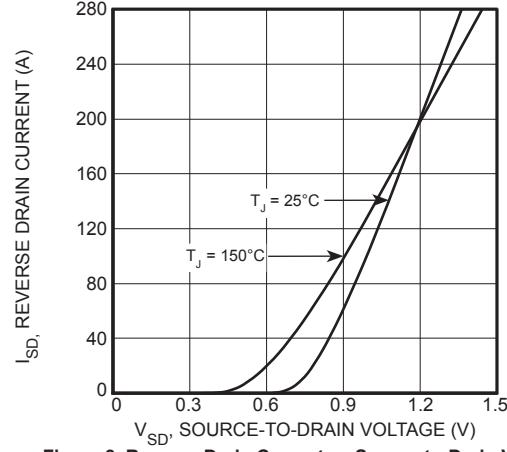


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage

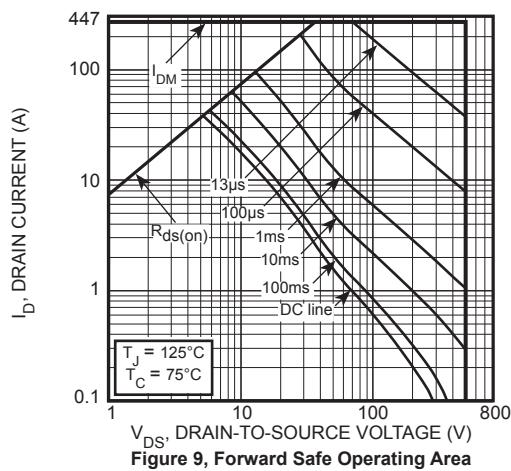


Figure 9, Forward Safe Operating Area

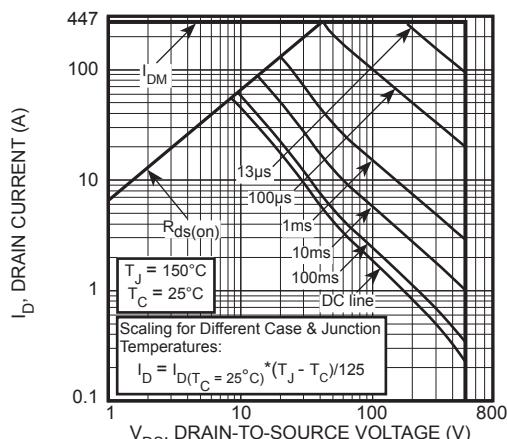


Figure 10, Maximum Forward Safe Operating Area

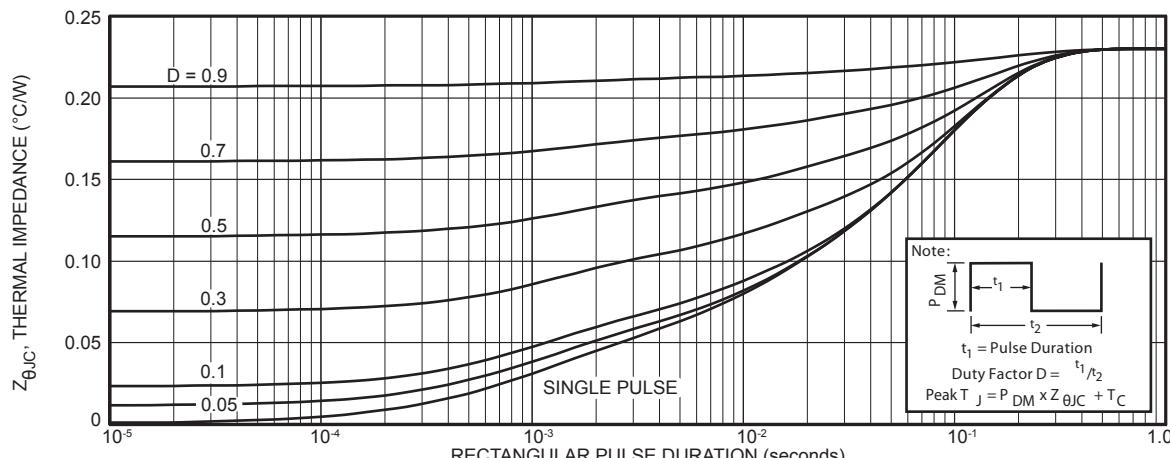
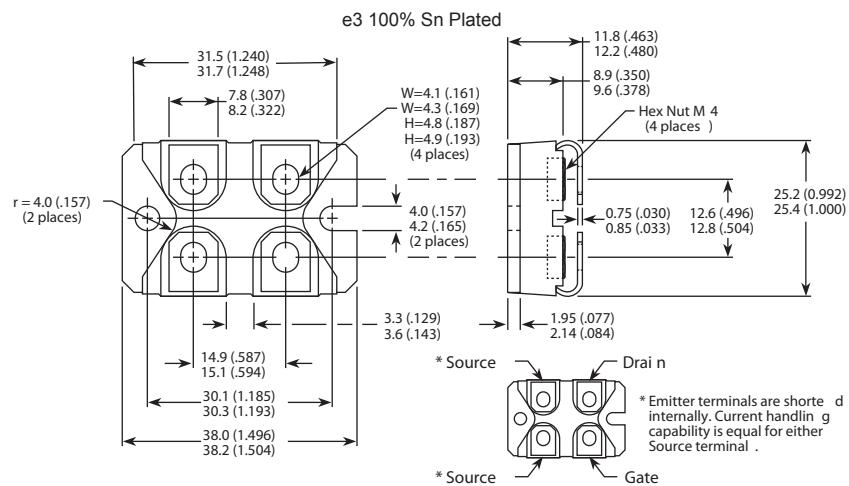


Figure 11. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

### SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)



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Электрон  
Связь**

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